Search Notes

Application/Control	No.	

Applicant(s)/Patent under Reexamination

IKEDA ET AL.

09/911,873 Examiner

Art Unit

Benny Q. Tieu

2614

	SEARCHED				
Class	Subclass	Date	Examiner		
455	92 414.1 414.3 432.3	4/15/2006	BQT		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	1			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST	5/26/2005	BQT	
EAST	4/15/2006	BQT	